## Notice of References Cited Application/Control No. 10/082,176 Examiner Rehana Perveen Applicant(s)/Patent Under Reexamination HASEGAWA, TOSHITAKA Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,822,432 B2	11-2004	Hilleary, Thomas N.	324/72
	В	US-6,526,507 B1	02-2003	Cromer et al.	713/162
	O	US-6,477,361 B1	11-2002	LaGrotta et al.	455/343.1
	ם	US-6,473,607 B1	10-2002	Shohara et al.	455/343.1
	ш	US-6,421,782 B1	07-2002	Yanagisawa et al.	713/201
	щ	US-6,189,108 B1	02-2001	Cromer et al.	713/340
	G	US-5,983,353 A	11-1999	McHann, Jr., Stanley E.	713/310
	Ι	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP000499564A2	08-1992	Europe	Budnik et al	G06F 1/26
	0					
	Р					
	Q					
	R					
	s					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.